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Datasheet of FDG326P - MOSFET P-CH 20V 1.5A SC70-6 Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

FAIRCHILD SEMICONDUCTOR TM January 2001

FDG326P

P-Channel 1.8V Specified PowerTrench® MOSFET

General Description

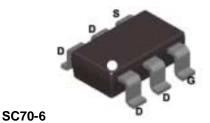
This P-Channel 1.8V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

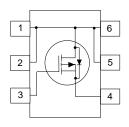
Applications

- · Battery management
- Load switch

Features

- $R_{DS(ON)} = 140 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$ −1.5 A, −20 V. $R_{DS(ON)} = 180 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$ $R_{\text{DS(ON)}}$ = 250 $m\Omega$ @ V_{GS} = -1.8~V
- · Low gate charge
- · High performance trench technology for extremely
- Compact industry standard SC70-6 surface mount package





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		± 8	V
I _D	Drain Current - Continuous	(Note 1a)	-1.5	A
	– Pulsed		-6	
P _D	Power Dissipation for Single Operation	(Note 1a)	0.75	W
		(Note 1b)	0.48	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	Note 1b)	260	°C/W
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Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.26	FDG326P	7"	8mm	3000 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-20			V
ΔBV _{DSS} ΔT, _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, Referenced to 25°C		-12		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μΑ
GSSF	Gate-Body Leakage, Forward	V _{GS} = 8 V, V _{DS} = 0 V			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)			I		
/ _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-0.9	-1.5	V
ΔV _{GS(th)} ΔT _J	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		2		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	V _{GS} = -4.5 V, I _D = -1.5 A V _{GS} = -2.5 V, I _D = -1.3 A V _{GS} = -1.8 V, I _D = -0.8 A V _{GS} = -4.5 V, I _D = -1.5 A, T _I = 125°C		105 140 210 125	140 180 250 200	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-6	_		Α
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -1.5 \text{ A}$		5.3		S
Dvnamio	Characteristics			I		
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V. } V_{GS} = 0 \text{ V.}$		467		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		85		pF
C _{rss}	Reverse Transfer Capacitance			38		pF
Switchin	ng Characteristics (Note 2)				•	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, I_D = 1 \text{ A},$		8	16	ns
r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		13	23	ns
t _{d(off)}	Turn-Off Delay Time			18	32	ns
t _f	Turn-Off Fall Time			8	16	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_D = -1.5 \text{ A},$		4.4	7	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		1.0		nC
Q _{gd}	Gate-Drain Charge			0.8		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings			•	•
I _s	Maximum Continuous Drain–Source				-0.62	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -0.62 \text{ A (Note 2)}$		-0.75	-1.2	V
						•

Notes

- a.) 170°C/W when mounted on a 1 in² pad of 2 oz. copper.
- b.) 260°C/W when mounted on a minimum pad.
- **2.** Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%

^{1.} $R_{\theta,JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



Typical Characteristics

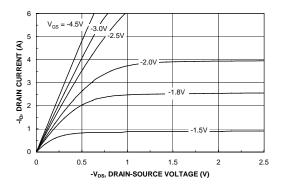


Figure 1. On-Region Characteristics.

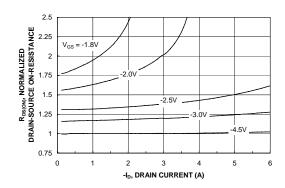


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

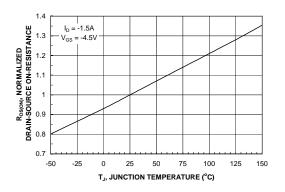


Figure 3. On-Resistance Variation with Temperature.

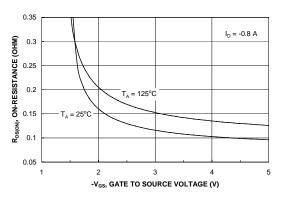


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

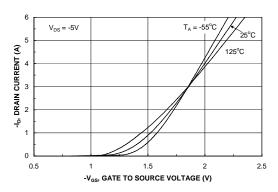


Figure 5. Transfer Characteristics.

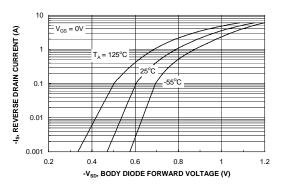
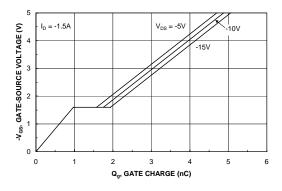


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



Typical Characteristics



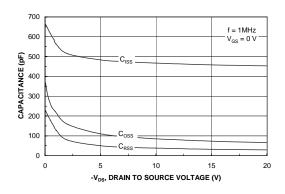


Figure 7. Gate Charge Characteristics.

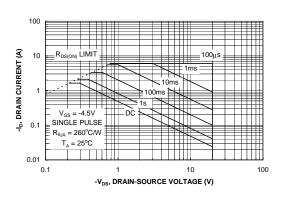


Figure 8. Capacitance Characteristics.

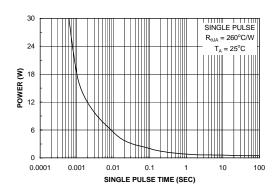


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

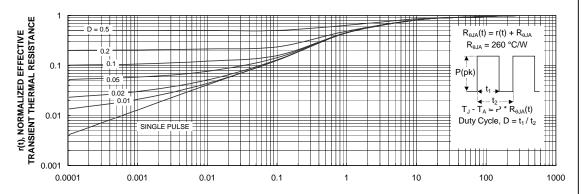


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient themal response will change depending on the circuit board design.



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Rev. H4